

# AO4485 40V P-Channel MOSFET

# **General Description**

The AO4485 uses advanced trench technology to provide excellent  $R_{\text{DS(ON)}}$  with low gate charge. This device is suitable for use as a DC-DC converter application.

# **Product Summary**

 $V_{DS}(V) = -40V$ 

 $I_D = -10A$   $(V_{GS} = -10V)$ 

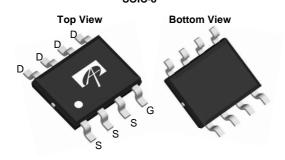
 $R_{DS(ON)} < 15 m\Omega \qquad \ (V_{GS} = -10 V)$ 

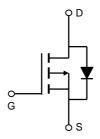
 $R_{DS(ON)} < 20m\Omega$  ( $V_{GS} = -4.5V$ )

100% UIS Tested 100% Rg Tested









| Absolute Maximum Ratings | T <sub>J</sub> =25℃ unless otherwise noted | l |
|--------------------------|--|---|
|--------------------------|--|---|

| Parameter  |                     | Symbol                            | 10 Sec | Steady State | Units |  |
|--|---------------------|-----------------------------------|--------|--------------|-------|--|
| Drain-Source Voltage                             |                     | $V_{DS}$                          | -40    |              | V     |  |
| Gate-Source Voltage                              |                     | $V_{GS}$                          | ±20    |              | V     |  |
| Continuous Drain                                 | T <sub>A</sub> =25℃ |                                   | -12    | -10          |       |  |
| Current <sup>A</sup>                             | T <sub>A</sub> =70℃ | I <sub>D</sub>                    | -9     | -8           | ٨     |  |
| Pulsed Drain Current <sup>B</sup>                |                     | I <sub>DM</sub>                   | -120   |              | Α     |  |
| Avalanche Current <sup>G</sup>                   |                     | I <sub>AR</sub>                   | -28    |              |       |  |
| Repetitive avalanche energy L=0.3mH <sup>G</sup> |                     | E <sub>AR</sub>                   | 118    |              | mJ    |  |
| Power Dissipation <sup>A</sup>                   | T <sub>A</sub> =25℃ | D                                 | 3.1    | 1.7          | W     |  |
|  | T <sub>A</sub> =70℃ | $-P_{D}$                          | 2.0    | 1.1          | VV    |  |
| Junction and Storage                             | Temperature Range   | T <sub>J</sub> , T <sub>STG</sub> | -55    | to 150       | C     |  |

| Thermal Characteristics               |              |                 |     |     |       |
|---------------------------------------|--------------|-----------------|-----|-----|-------|
| Parameter                             |              | Symbol          | Тур | Max | Units |
| Maximum Junction-to-Ambient A         | t ≤ 10s      | D               | 31  | 40  | €/M   |
| Maximum Junction-to-Ambient A         | Steady State | $R_{	heta JA}$  | 59  | 75  | °C/W  |
| Maximum Junction-to-Lead <sup>C</sup> | Steady State | $R_{\theta JL}$ | 16  | 24  | ℃/W   |

### Electrical Characteristics (T<sub>J</sub>=25℃ unless otherwise noted)

| Symbol   | Parameter                           | Conditions   | Min  | Тур  | Max  | Units |  |
|--|-------------------------------------|--|------|------|------|-------|--|
| STATIC F   | PARAMETERS                          |  |      |      |      |       |  |
| BV <sub>DSS</sub>                                | Drain-Source Breakdown Voltage      | $I_D = -250 \mu A, V_{GS} = 0 V$                                   | -40  |      |      | V     |  |
| I <sub>DSS</sub> Zero Gate Voltage Drain Current | $V_{DS} = -40V, V_{GS} = 0V$        |  |      | -1   | μΑ   |       |  |
| I <sub>DSS</sub>                                 | Zero Gate Voltage Drain Gurrent     | T <sub>J</sub> = 55℃   |      |      | -5   | μΑ    |  |
| $I_{GSS}$  | Gate-Body leakage current           | $V_{DS} = 0V, V_{GS} = \pm 20V$                                    |      |      | ±100 | nA    |  |
| $V_{GS(th)}$                                     | Gate Threshold Voltage              | $V_{DS} = V_{GS} I_D = -250 \mu A$                                 | -1.7 | -1.9 | -2.5 | V     |  |
| $I_{D(ON)}$                                      | On state drain current              | $V_{GS} = -10V, V_{DS} = -5V$                                      | -120 |      |      | Α     |  |
|  |                                     | $V_{GS} = -10V, I_D = -10A$  |      | 12.5 | 15   |       |  |
| R <sub>DS(ON)</sub>                              | Static Drain-Source On-Resistance   | T <sub>J</sub> =125℃   |      | 19   | 23   | mΩ    |  |
|  |                                     | $V_{GS} = -4.5V, I_D = -8A$  |      | 16   | 20   |       |  |
| g <sub>FS</sub>                                  | Forward Transconductance            | $V_{DS} = -5V, I_{D} = -10A$                                       |      | 25   |      | S     |  |
| $V_{SD}$   | Diode Forward Voltage               | $I_S = -1A, V_{GS} = 0V$   |      | -0.7 | -1   | V     |  |
| Is   | Maximum Body-Diode Continuous Curre | ent  |      |      | -3   | Α     |  |
| DYNAMIC  | PARAMETERS                          |  |      |      |      |       |  |
| C <sub>iss</sub>                                 | Input Capacitance                   |  |      | 2500 | 3000 | pF    |  |
| C <sub>oss</sub>                                 | Output Capacitance                  | $V_{GS}$ =0V, $V_{DS}$ =-20V, f=1MHz                               |      | 260  |      | pF    |  |
| $C_{rss}$  | Reverse Transfer Capacitance        |  |      | 180  |      | pF    |  |
| $R_g$  | Gate resistance                     | $V_{GS}$ =0V, $V_{DS}$ =0V, f=1MHz                                 | 2.5  | 4    | 6    | Ω     |  |
| SWITCHI  | NG PARAMETERS                       |  |      |      |      |       |  |
| Q <sub>g</sub> (10V)                             | Total Gate Charge                   |  |      | 42   | 55   | nC    |  |
| Q <sub>g</sub> (4.5V)                            | Total Gate Charge                   | V <sub>GS</sub> =-10V, V <sub>DS</sub> =-20V, I <sub>D</sub> =-10A |      | 18.6 |      | nC    |  |
| $Q_{gs}$   | Gate Source Charge                  | VGS= 10 V, VDS= 20 V, 1D= 10 / V                                   |      | 7    |      | nC    |  |
| $Q_{gd}$   | Gate Drain Charge                   |  |      | 8.6  |      | nC    |  |
| t <sub>D(on)</sub>                               | Turn-On DelayTime                   |  |      | 9.4  |      | ns    |  |
| t <sub>r</sub>                                   | Turn-On Rise Time                   | $V_{GS}$ =-10V, $V_{DS}$ =-20V,                                    |      | 20   |      | ns    |  |
| $t_{D(off)}$                                     | Turn-Off DelayTime                  | $R_L = 2\Omega$ , $R_{GEN} = 3\Omega$                              |      | 55   |      | ns    |  |
| t <sub>f</sub>                                   | Turn-Off Fall Time                  |  |      | 30   |      | ns    |  |
| t <sub>rr</sub>                                  | Body Diode Reverse Recovery Time    | I <sub>F</sub> =-10A, dI/dt=100A/μs                                |      | 38   | 49   | ns    |  |
| $Q_{rr}$   | Body Diode Reverse Recovery Charge  | I <sub>F</sub> =-10A, dI/dt=100A/μs                                |      | 47   |      | nC    |  |

A: The value of R  $_{6UA}$  is measured with the device mounted on  $1\text{in}^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A = 25$ °C. The value in any given application depends on the user's specific board design.

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B: Repetitive rating, pulse width limited by junction temperature.

C. The R  $_{\theta JA}$  is the sum of the thermal impedence from junction to lead R  $_{\theta JL}$  and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using t  $\le$  300 $\mu$ s pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25$ °C. The SOA curve provides a single pulse rating.

F. The current rating is based on the  $t \leqslant 10\text{s}$  thermal resistance rating.

G.  $E_{AR}$  and  $I_{AR}$  ratings are based on low frequency and duty cycles to keep  $T_j$ =25C.

### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

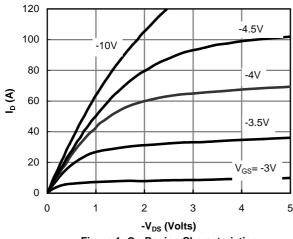


Figure 1: On-Region Characteristics

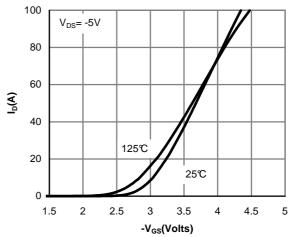


Figure 2: Transfer Characteristics

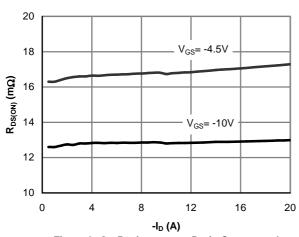


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

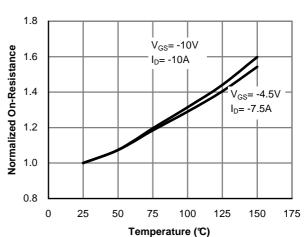


Figure 4: On-Resistance vs. Junction Temperature

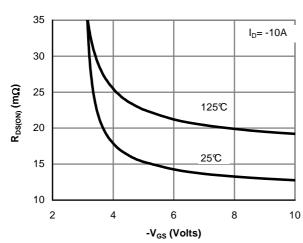


Figure 5: On-Resistance vs. Gate-Source Voltage

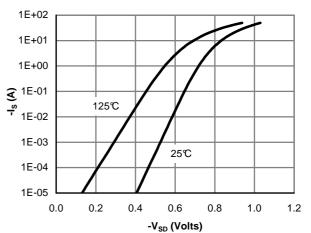


Figure 6: Body-Diode Characteristics

### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

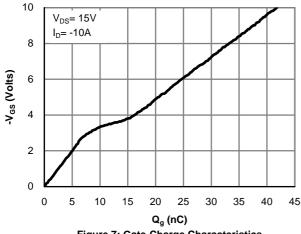


Figure 7: Gate-Charge Characteristics

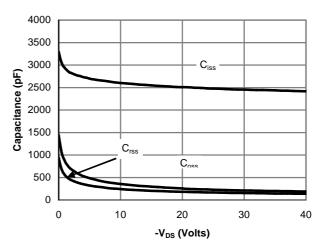


Figure 8: Capacitance Characteristics

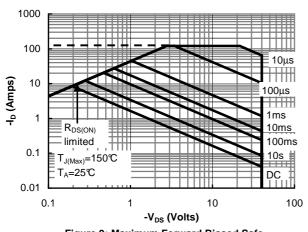


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

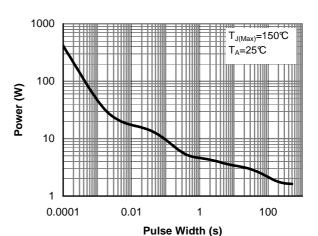


Figure 10: Single Pulse Power Rating Junctionto-Ambient (Note E)

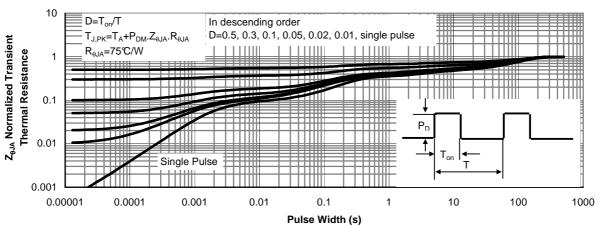


Figure 11: Normalized Maximum Transient Thermal Impedance(Note E)

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